16-bit Registered Transceivers with 3-state Outputs

# **HITACHI**

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#### **Description**

The HD74ALVCH16543 can be used as two 8-bit transceivers or one 16-bit transceiver. Separate latch enable ( $\overline{LEAB}$  or  $\overline{LEBA}$ ) and output enable ( $\overline{OEAB}$  or  $\overline{OEBA}$ ) inputs are provided for each register to permit independent control in either direction of data flow. The A to B enable ( $\overline{CEAB}$ ) input must be low in order to enter data from A or to output data from B. If  $\overline{CEAB}$  is low and  $\overline{LEAB}$  is low, the A to B latches are transparent; a subsequent low to high transition of  $\overline{LEAB}$  puts the A latches in the storage mode. With  $\overline{CEAB}$  and  $\overline{OEAB}$  both low, the 3-state B outputs are active and reflect the data present at the output of the A latches. Data flow from B to A is similar but requires using  $\overline{CEBA}$ ,  $\overline{LEBA}$ , and  $\overline{OEBA}$ . Active bus hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

#### **Features**

- $V_{CC} = 2.3 \text{ V to } 3.6 \text{ V}$
- Typical  $V_{OL}$  ground bounce < 0.8 V (@ $V_{CC}$  = 3.3 V, Ta = 25°C)
- Typical  $V_{OH}$  undershoot > 2.0 V (@ $V_{CC}$  = 3.3 V, Ta = 25°C)
- High output current  $\pm 24$  mA (@V<sub>CC</sub> = 3.0 V)
- Bus hold on data inputs eliminates the need for external pullup / pulldown resistors



### **Function Table** \*1

Inputs		Output B		
CEAB	LEAB	OEAB	Α	
Н	X	X	Х	Z
X	X	Н	X	Z
L	Н	L	Х	B <sub>0</sub> *2
L	L	L	L	L
L	L	L	Н	Н

H : High level

L : Low level

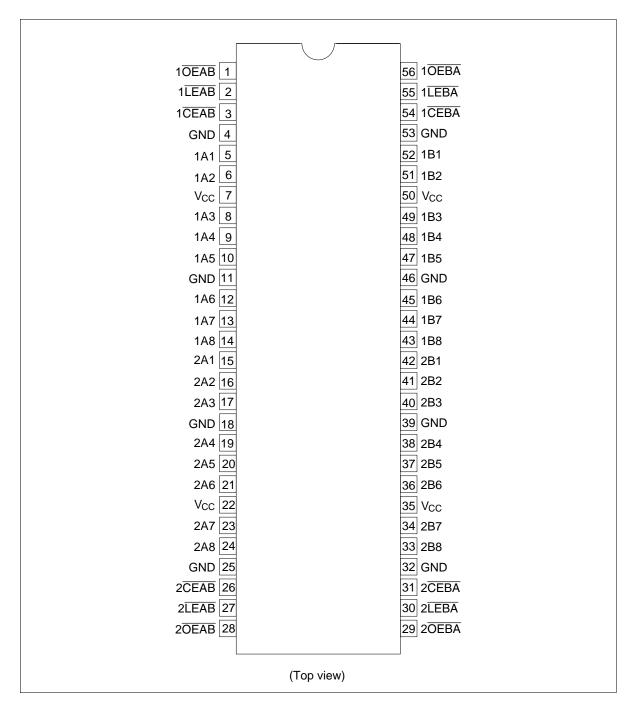
X : Immaterial

Z: High impedance

Notes 1. A to B data flow is shown; B to A flow control is the same except that it uses  $\overline{\text{CEBA}}$ ,  $\overline{\text{LEBA}}$ , and  $\overline{\text{OFBA}}$ .

2. Output level before the indicated steady state input conditions were established.

## **Pin Arrangement**



#### **Absolute Maximum Ratings**

Item	Symbol	Ratings	Unit	Conditions
Supply voltage	V <sub>cc</sub>	-0.5 to 4.6	V	_
Input voltage *1, 2	V <sub>I</sub>	-0.5 to 4.6	V	Except I/O ports
		$-0.5$ to $V_{CC}$ +0.5		I/O ports
Output voltage *1, 2	Vo	$-0.5$ to $V_{cc}$ +0.5	V	
Input clamp current	I <sub>IK</sub>	-50	mA	V <sub>1</sub> < 0
Output clamp current	I <sub>ok</sub>	±50	mA	$V_{o} < 0 \text{ or } V_{o} > V_{cc}$
Continuous output current	Io	±50	mA	$V_o = 0$ to $V_{cc}$
		±100		
Maximum power dissipation at Ta = 55°C (in still air) *3	P <sub>T</sub>	1	W	TSSOP
Storage temperature	Tstg	-65 to 150	°C	

Notes:

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute maximum rated conditions for extended periods may affect device reliability.

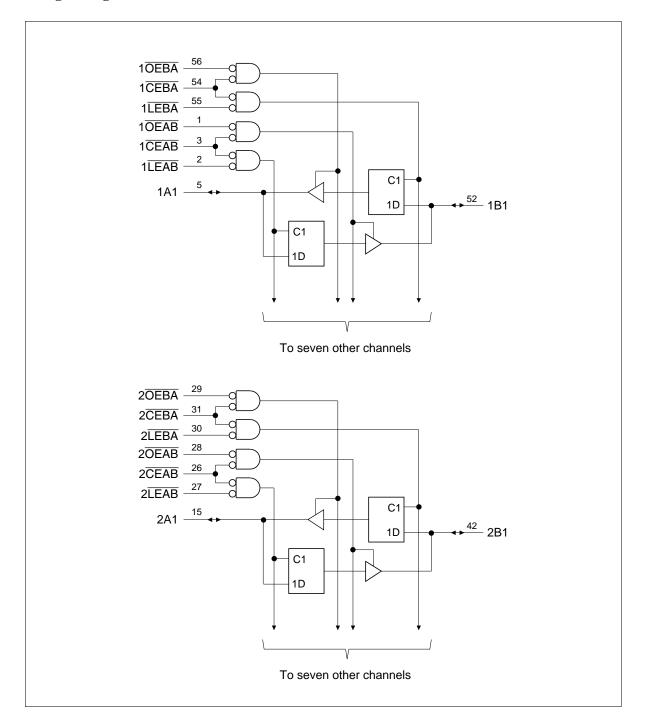
- 1. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.
- 2. This value is limited to 4.6 V maximum.
- 3. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.

#### **Recommended Operating Conditions**

Item	Symbol	Min	Max	Unit	Conditions
Supply voltage	V <sub>CC</sub>	2.3	3.6	V	
Input voltage	V <sub>I</sub>	0	V <sub>cc</sub>	V	
Output voltage	V <sub>o</sub>	0	$V_{cc}$	V	
High level output current	I <sub>OH</sub>	_	-12	mA	V <sub>CC</sub> = 2.3 V
		_	-12		$V_{CC} = 2.7 \text{ V}$
		_	-24		$V_{CC} = 3.0 \text{ V}$
Low level output current	I <sub>OL</sub>	_	12	mA	V <sub>CC</sub> = 2.3 V
		_	12		$V_{CC} = 2.7 \text{ V}$
		_	24		$V_{CC} = 3.0 \text{ V}$
Input transition rise or fall rate	Δt / Δν	0	10	ns / V	
Operating temperature	Та	-40	85	°C	

Note: Unused control inputs must be held high or low to prevent them from floating.

# Logic Diagram



## **Electrical Characteristics** ( $Ta = -40 \text{ to } 85^{\circ}\text{C}$ )

Item	Symbol	V <sub>cc</sub> (V) *1	Min	Max	Unit	Test Conditions
Input voltage	V <sub>IH</sub>	2.3 to 2.7	1.7	_	V	
		2.7 to 3.6	2.0	_	<del></del>	
	V <sub>IL</sub>	2.3 to 2.7	_	0.7	_	
		2.7 to 3.6	_	0.8	<del>-</del>	
Output voltage	V <sub>OH</sub>	Min to Max	V <sub>cc</sub> -0.2	_	V	$I_{OH} = -100 \mu A$
		2.3	2.0	_	_	$I_{OH} = -6 \text{ mA}, V_{IH} = 1.7 \text{ V}$
		2.3	1.7	_	<del></del>	$I_{OH} = -12 \text{ mA}, V_{IH} = 1.7 \text{ V}$
		2.7	2.2	_	<del></del>	$I_{OH} = -12 \text{ mA}, V_{IH} = 2.0 \text{ V}$
		3.0	2.4	_	_	$I_{OH} = -12 \text{ mA}, V_{IH} = 2.0 \text{ V}$
		3.0	2.0	_	<del></del>	$I_{OH} = -24 \text{ mA}, V_{IH} = 2.0 \text{ V}$
	V <sub>OL</sub>	Min to Max	_	0.2	<del></del>	I <sub>OL</sub> = 100 μA
		2.3	_	0.4	_	$I_{OL} = 6 \text{ mA}, V_{IL} = 0.7 \text{ V}$
		2.3	_	0.7	<del></del>	$I_{OL} = 12 \text{ mA}, V_{IL} = 0.7 \text{ V}$
		2.7	_	0.4	<del></del>	$I_{OL} = 12 \text{ mA}, V_{IL} = 0.8 \text{ V}$
		3.0	_	0.55	_	$I_{OL} = 24 \text{ mA}, V_{IL} = 0.8 \text{ V}$
Input current	I <sub>IN</sub>	3.6	_	±5	μΑ	$V_{IN} = V_{CC}$ or GND
	I <sub>IN (hold)</sub>	2.3	45	_	<del></del>	V <sub>IN</sub> = 0.7 V
		2.3	-45	_	_	V <sub>IN</sub> = 1.7 V
		3.0	75	_	_	V <sub>IN</sub> = 0.8 V
		3.0	<b>-75</b>	_	<del></del>	V <sub>IN</sub> = 2.0 V
		3.6	_	±500	_	$V_{IN} = 0 \text{ to } 3.6 \text{ V}$
Off state output current	² I <sub>oz</sub>	3.6	_	±10	μΑ	$V_{OUT} = V_{CC}$ or GND
Quiescent supply curren	t I <sub>cc</sub>	3.6	_	40	μΑ	$V_{IN} = V_{CC}$ or GND
	$\Delta I_{CC}$	3.0 to 3.6	_	750	μΑ	$V_{IN}$ = one input at ( $V_{CC}$ -0.6) V, other inputs at $V_{CC}$ or GND

Notes: 1. For conditions shown as Min or Max, use the appropriate values under recommended operating conditions.

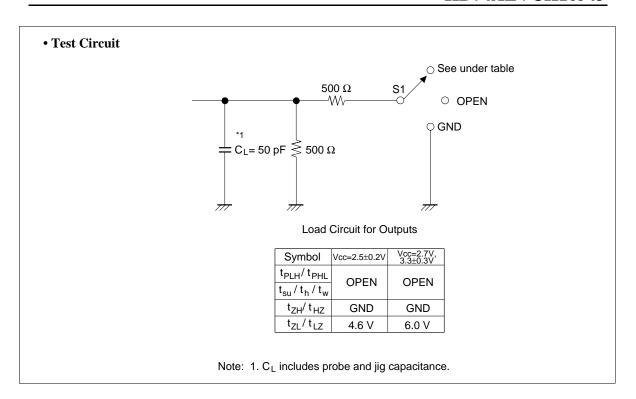
2. For I/O ports, the parameter  $\rm I_{\rm OZ}$  includes the input leakage current.

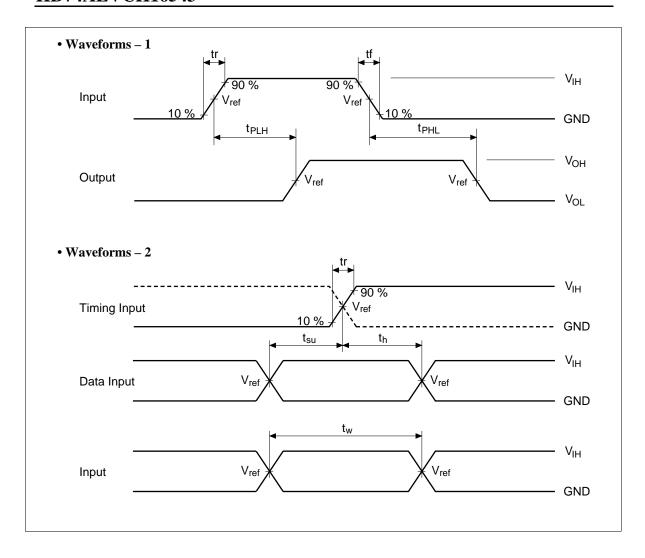
# **Switching Characteristics** (Ta = -40 to 85°C)

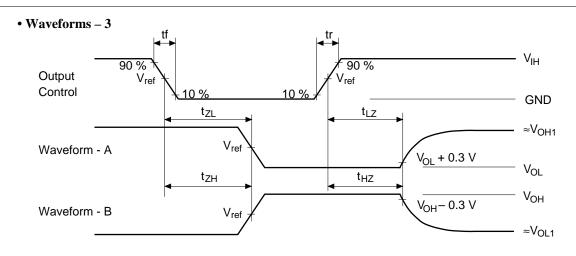
Item	Symbol	V <sub>cc</sub> (V)	Min	Тур	Max	Unit	FROM (Input)	TO (Output)
Propagation delay time	t <sub>PLH</sub>	2.5±0.2	1.0	_	5.1	ns	A or B	B or A
	$t_{\tiny PHL}$	2.7	_	_	4.8			
		3.3±0.3	1.0	_	4.3			
		2.5±0.2	1.1	_	6.5		LE	A or B
		2.7	_	_	6.2			
		3.3±0.3	1.1	_	5.0			
Output enable time	t <sub>zH</sub>	2.5±0.2	1.0	_	7.2	ns	CE	A or B
	$\mathbf{t}_{\scriptscriptstyle ZL}$	2.7	_	_	6.9			
		3.3±0.3	1.0	_	5.6	_		
		2.5±0.2	1.0	_	6.8		ŌĒ	A or B
		2.7	_	_	6.3			
		3.3±0.3	1.0	_	5.3	_		
Output disable time	t <sub>HZ</sub>	2.5±0.2	2.0	_	6.1	ns	CE	A or B
	$t_{\scriptscriptstyle LZ}$	2.7	_	_	6.2			
		3.3±0.3	1.5	_	5.1	_		
		2.5±0.2	1.6	_	5.7		ŌĒ	A or B
		2.7	_	_	4.8			
		3.3±0.3	1.1	_	4.6			
Input capacitance	C <sub>IN</sub>	3.3	_	3.5	_	pF	Control in	puts
Output capacitance	$C_{IN/O}$	3.3		7.0		pF	A or B po	orts

## **Switching Characteristics** (Ta = -40 to 85°C) (Cont)

Item	Symbol	$V_{cc}$ (V)	Min	Тур	Max	Unit	FROM (Input)
Setup time	t <sub>su</sub>	2.5±0.2	1.2	_	_	ns	Data before <del>CE</del> ↑
		2.7	1.5	_	_		
		3.3±0.3	1.2	_	_		
		2.5±0.2	1.2	_	_		Data before <del>LE</del> ↑
		2.7	1.5	_	_	<del>-</del>	CE "L"
		3.3±0.3	1.2	_	_	<del>-</del>	
Hold time	t <sub>h</sub>	2.5±0.2	1.2	_	_	ns	Data after <del>CE</del> ↑
		2.7	8.0	_	_	<del>-</del>	
		3.3±0.3	1.3	_	_		
		2.5±0.2	1.2	_	_	<del>-</del>	Data after <u>LE</u> ↑
		2.7	8.0	_	_	_	CE "L"
		3.3±0.3	1.3	_	_	<del>-</del>	
Pulse width	t <sub>w</sub>	2.5±0.2	3.3	_	_	ns	CE or LE "L"
		2.7	3.3	_	_	_	
		3.3±0.3	3.3	_	_	_	







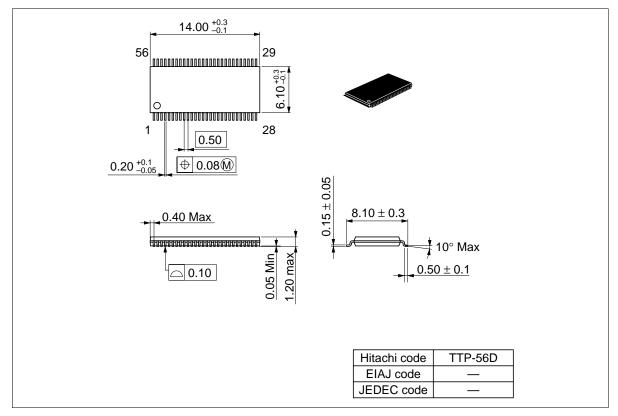
TEST	Vcc=2.5±0.2V	Vcc=2.7V, 3.3±0.3V
$V_{IH}$	2.3 V	2.7 V
$V_{ref}$	1.2 V	1.5 V
V <sub>OH1</sub>	2.3 V	3.0 V
V <sub>OL1</sub>	GND	GND

Notes: 1. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Zo = 50  $\Omega$ , tr  $\leq$  2.5 ns, tf  $\leq$  2.5 ns.

- 2. Waveform A is for an output with internal conditions such that the output is low except when disabled by the output control.
- 3. Waveform B is for an output with internal conditions such that the output is high except when disabled by the output control.
- 4. The output are measured one at a time with one transition per measurement.

## **Package Dimensions**

Unit: mm



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